

TEST REPORT

Equipment Type: BYKC-FRS8X-VER1.2
Model Name: Boyi scientific and technological innovation
Brand Name: IEEE Std 149-2021
Test Standard: May 08, 2024
Sample Arrival Date: May 08, 2024
Test Date: May 09, 2024
Date of Issue:

ISSUED BY:

Shenzhen BALUN Technology Co., Ltd.



Tested by: Mai Jintian

Checked by: Xia Long

Approved by: Tolan Tu
(Testing Director)

Mai Jintian

Xia Long

Tolan Tu

Revision History

Version	Issue Date	Revisions
<u>Rev. 01</u>	<u>May 09, 2024</u>	<u>Initial Issue</u>

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1 GENERAL INFORMATION

1.1 Test Laboratory

Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

1.2 Test Location

Name	Shenzhen BALUN Technology Co., Ltd.
Location	☒ Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
	☐ 1/F, Building B, Ganghongji High-tech Intelligent Industrial Park, No. 1008, Songbai Road, Yangguang Community, Xili Sub-district, Nanshan District, Shenzhen, Guangdong Province, P. R. China

2 PRODUCT INFORMATION

2.2 Manufacturer Information

Manufacturer	Shenzhen Boyi Innovation Technology Co., Ltd
Address	North, 5 / F, Building 3, Tea West, Zone A, Huafeng First Science Park, Hangcheng Street, Baoan District, Shenzhen

2.3 General Description for Equipment under Test (EUT)

EUT Name	BYKC68MS-AK
Model Name Under Test	BYKC-FRS8X-VER1.2
Antenna Type	PCB Antenna
Dimensions	19.0*3.5 mm

2.4 Ancillary Equipment

Note: Not applicable.

2.5 Technical Information

Frequency Range	2402MHz ~ 2480MHz
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3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
1	IEEE Std 149-2021	IEEE Standard Test Procedures for Antennas

3.2 Test Verdict

Report Section	Description	Remark
ANNEX A.1	Gain and Efficiency	--
ANNEX B	Radiation Pattern	--

3.3 Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Item	Uncertainty
VSWR(S11)	± 0.61
Gain	$\pm 1.92\text{dB}$

4 GENERAL TEST CONFIGURATIONS

4.1 Test Condition

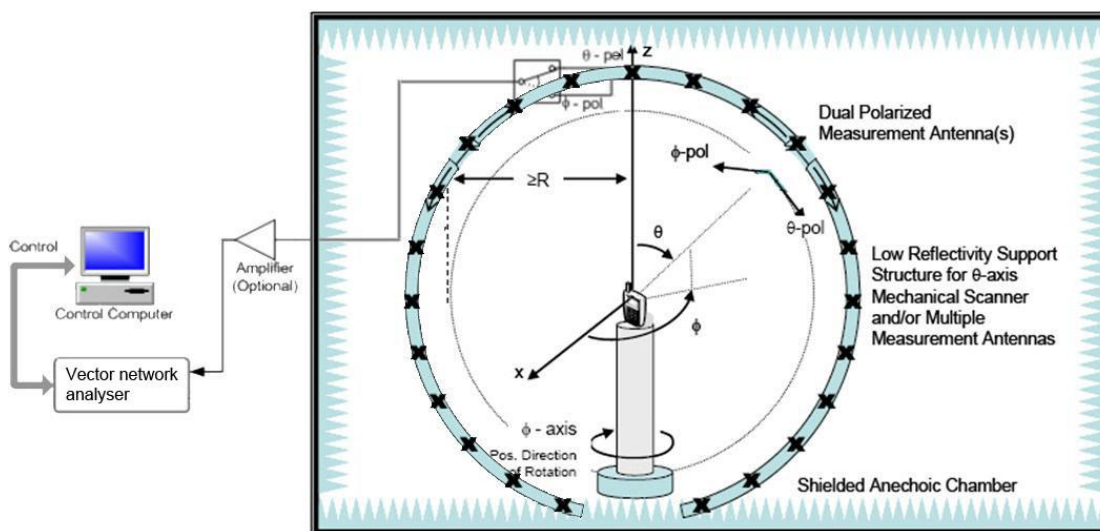
Environment Parameter	Selected Values During Tests			
	Ambient Pressure (KPa)	Temperature (°C)	Voltage	Relative Humidity (%)
Normal Temperature, Normal Voltage (NTNV)	101	21.5	N/A	43

4.2 Test Equipment List

Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
SG24 Multi-probe Antenna Measurement System	SATIMO	SG24-L	1101855- 0001	2021.11.12	2024.11.11
Vector Network Analyzer	Agilent	E5071B	MY42404001	2024.01.16	2025.01.15
Description	Manufacturer	Name		Version	
Test Software	MVG	SPM		V 1.8	

4.3 Test Setup

4.3.1 Antenna gain, efficiency and radiation pattern test setup



4.4 Test Frequencies

Test Frequencies	2402MHz, 2440MHz, 2480MHz
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ANNEX A TEST RESULTS

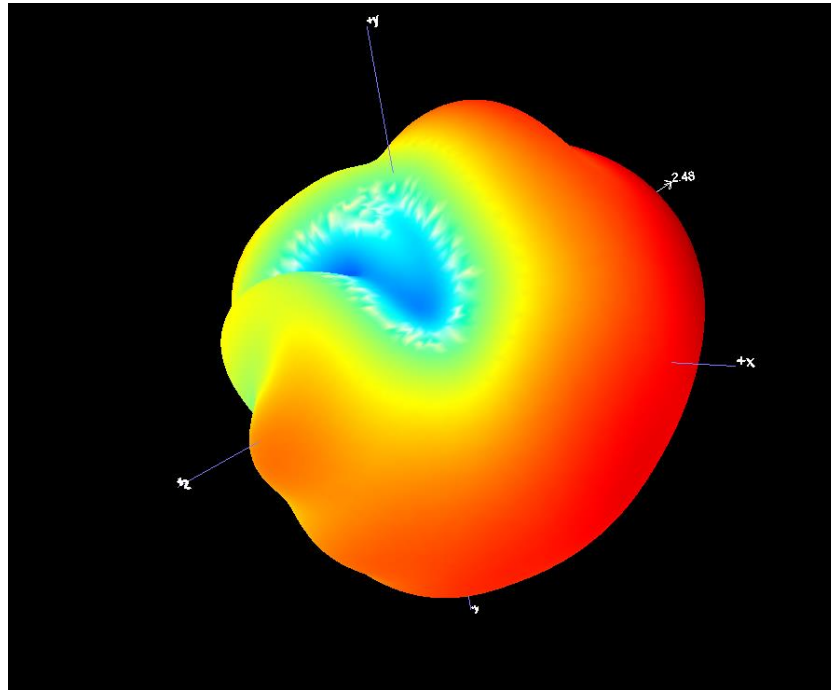
A.1 Gain and Efficiency

Frequency	Gain (dBi)	Efficiency (%)
2402MHz	2.48	41
2440MHz	2.31	38
2480MHz	1.55	36

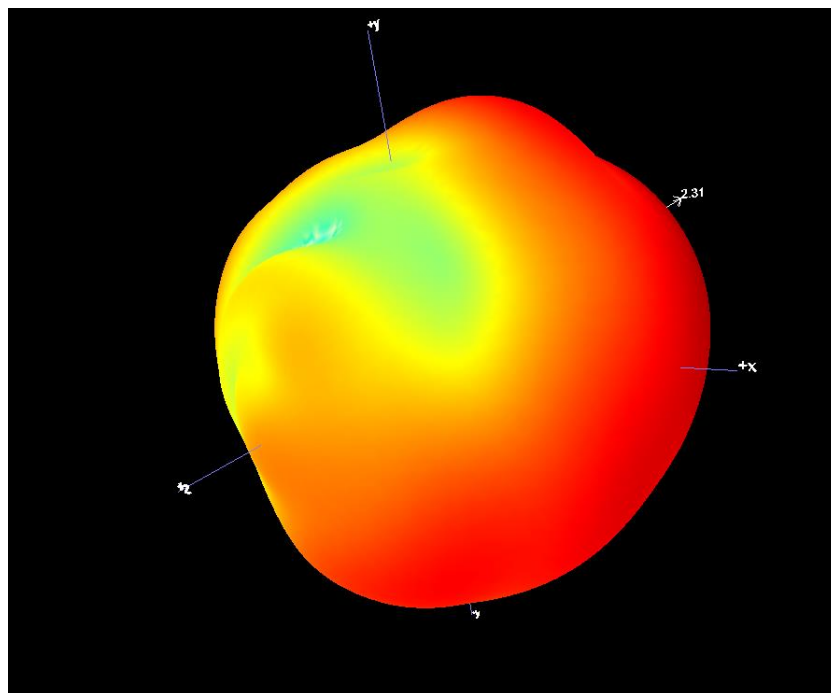
ANNEX B RADIATION PATTERN

B.1 3D Pattern

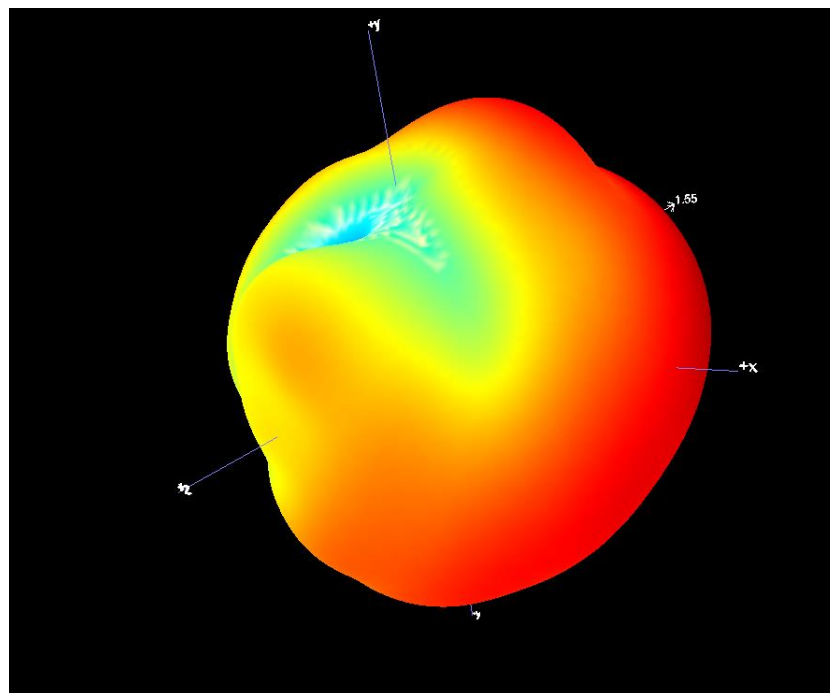
B1.1 3D Pattern for 2402MHz



B1.2 3D Pattern for 2440MHz



B1.3 3D Pattern for 2480MHz



B.2 1D Radiation Pattern

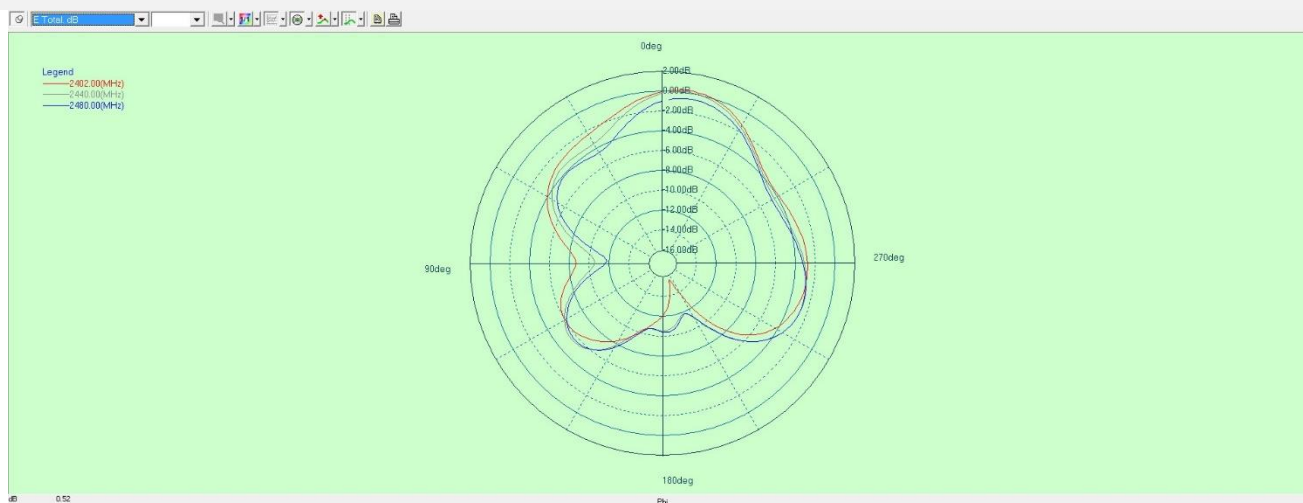
B2.1 PHI=0



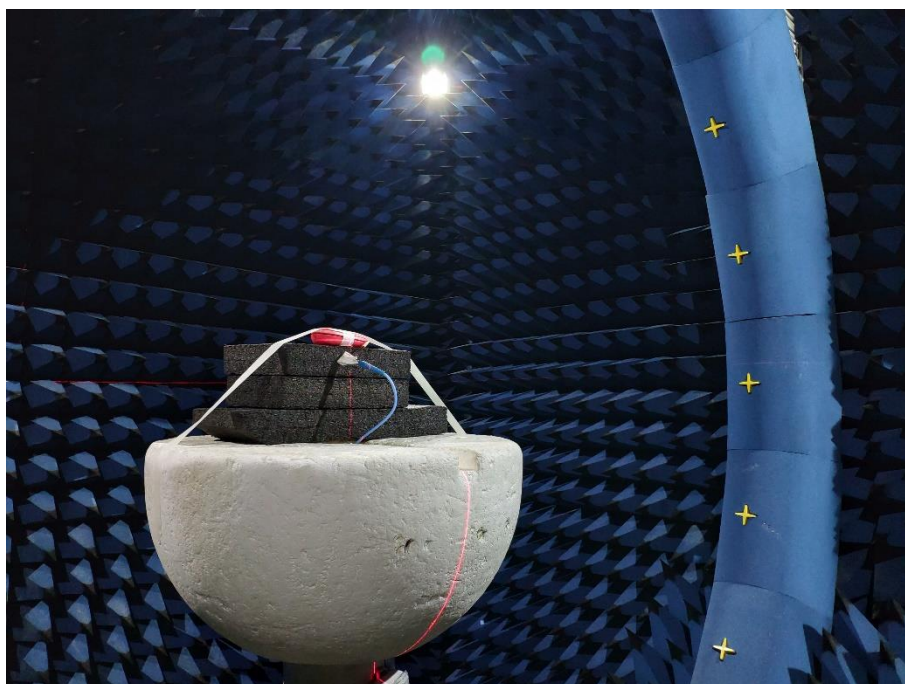
B2.2 PHI=90



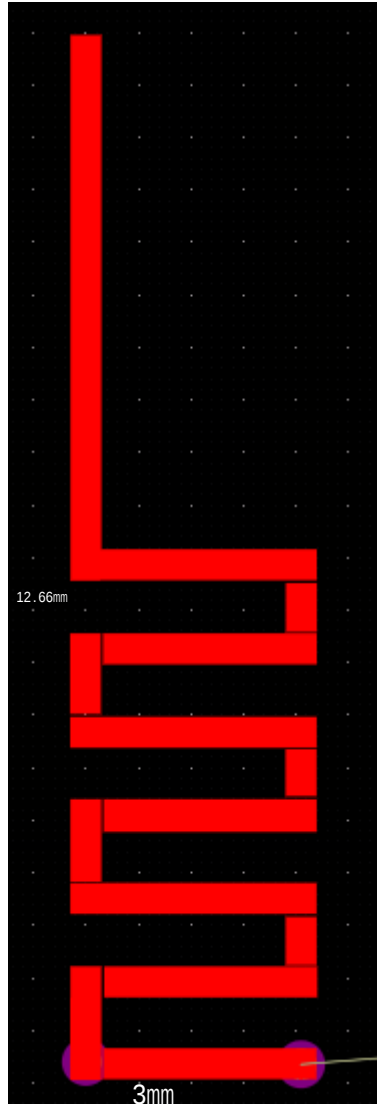
B2.3 THETA=90



ANNEX C TEST SETUP PHOTO



ANNEX D EUT PHOTO



Statement

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--END OF REPORT--